## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination HUEMPEL ET AL. Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	C	Kitaoka et al, Planta Medica, 64, p.511-515 (1998)						
	V	Miyamoto et al, Planta Medica, 64, p.516-519 (1998)						
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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